

DIDI VFET

SONY VFET Differential In

JFET - EliteSiC - UJ4N Differential Out

Pure Class A - Constant Current

Wideband Transformer Coupled

Assymetric Balanced Singled Ended

Autobias Amplifier

Monoblock

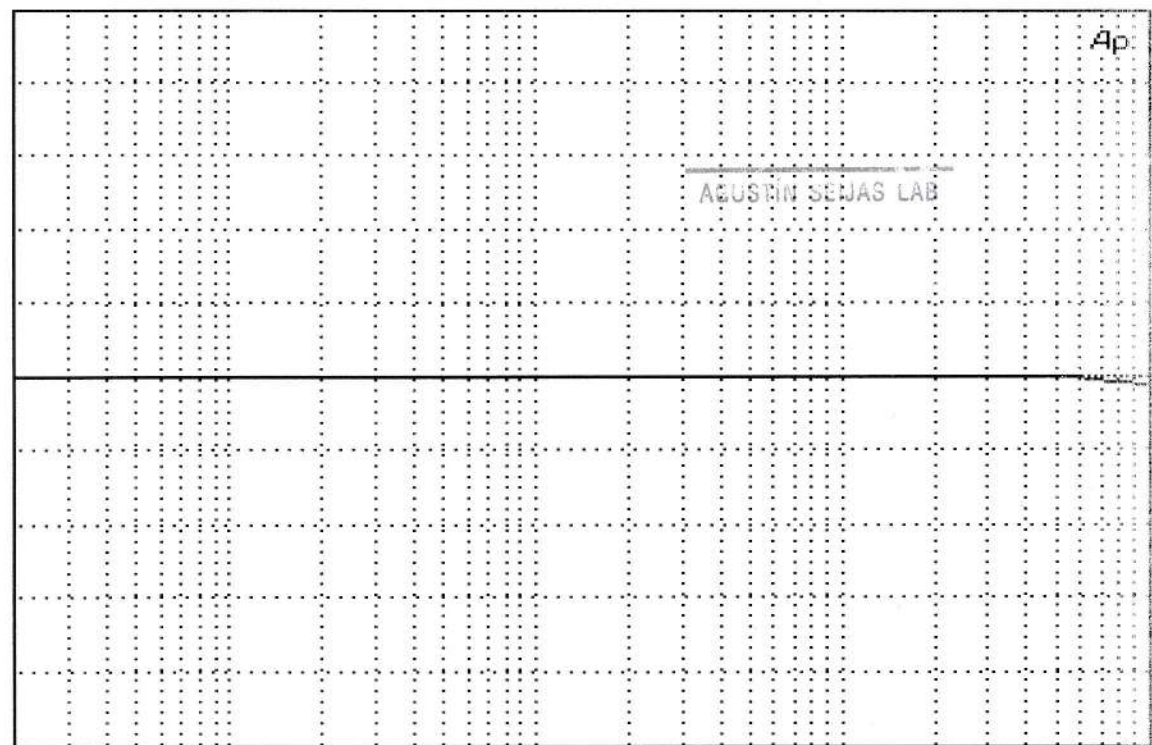
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0 dBr=11.072 V

10.00dBr

AMPL A
0 dBr

-10.00dBr



20.000 Hz LOG FREQUENCY 100.00kHz
SETTINGS (UN-WTD <10 Hz - >300 kHz GEN:SINE 1.594 V)

GEN FREQ	AMPL	A	GEN FREQ	AMPL	A	GEN FREQ	AMPL	A	Ap
20.00 Hz	-0.02 dBr		454.1 Hz	0.00 dBr		10.313kHz	-0.03 dBr		
26.56 Hz	-0.02 dBr		603.2 Hz	0.00 dBr		13.699kHz	-0.03 dBr		
35.28 Hz	-0.02 dBr		801.3 Hz	0.00 dBr		18.196kHz	-0.04 dBr		
46.87 Hz	-0.02 dBr		1.064 kHz	0.00 dBr		24.170kHz	-0.04 dBr		
62.25 Hz	-0.01 dBr		1.413 kHz	0.00 dBr		32.104kHz	-0.04 dBr		
82.69 Hz	-0.01 dBr		1.877 kHz	0.00 dBr		42.644kHz	-0.02 dBr		
109.8 Hz	-0.01 dBr		2.494 kHz	0.00 dBr		56.643kHz	0.00 dBr		
145.9 Hz	-0.01 dBr		3.313 kHz	0.00 dBr		75.238kHz	-0.16 dBr		
193.7 Hz	-0.01 dBr		4.400 kHz	0.00 dBr		100.00kHz	-0.21 dBr		
257.4 Hz	0.00 dBr		5.845 kHz	-0.01 dBr					
341.9 Hz	0.00 dBr		7.764 kHz	-0.02 dBr					

GEN FREQ	THD+N	A	GEN FREQ	THD+N	A	GEN FREQ	THD+N	A	Ap
20.00 Hz	0.520 %		251.7 Hz	0.449 %		3.169 kHz	0.439 %		
25.17 Hz	0.496 %		316.9 Hz	0.443 %		3.990 kHz	0.441 %		
31.69 Hz	0.501 %		399.0 Hz	0.445 %		5.023 kHz	0.445 %		
39.90 Hz	0.489 %		502.3 Hz	0.446 %		6.324 kHz	0.460 %		
50.23 Hz	0.484 %		632.4 Hz	0.445 %		7.962 kHz	0.469 %		
63.24 Hz	0.479 %		796.2 Hz	0.445 %		10.023kHz	0.485 %		
79.62 Hz	0.468 %		1.002 kHz	0.445 %		12.619kHz	0.507 %		
100.2 Hz	0.470 %		1.261 kHz	0.444 %		15.886kHz	0.534 %		
126.1 Hz	0.460 %		1.588 kHz	0.441 %		20.000kHz	0.554 %		
158.8 Hz	0.455 %		2.000 kHz	0.443 %					
200.0 Hz	0.450 %		2.517 kHz	0.437 %					

IMD A LEVEL A
1.67 % 9.138 V

GEN:IMD 1.594 V 70Hz/8kHz

Ap

GEN FREQ	PHASE	A-G	GEN FREQ	PHASE	A-G	GEN FREQ	PHASE	A-G	Ap
20.00 Hz	-0.5	deg	250.0 Hz	-0.3	deg	3.150 kHz	0.3	deg	
25.00 Hz	-0.5	deg	315.0 Hz	-0.2	deg	4.000 kHz	0.4	deg	
31.50 Hz	-0.4	deg	400.0 Hz	-0.2	deg	5.000 kHz	0.6	deg	
40.00 Hz	-0.4	deg	500.0 Hz	-0.2	deg	6.300 kHz	0.8	deg	
50.00 Hz	-0.4	deg	630.0 Hz	-0.2	deg	8.000 kHz	1.1	deg	
63.00 Hz	-0.3	deg	800.0 Hz	-0.1	deg	10.000kHz	1.4	deg	
80.00 Hz	-0.3	deg	1.000 kHz	-0.1	deg	12.500kHz	1.8	deg	
100.0 Hz	-0.3	deg	1.250 kHz	0.0	deg	16.000kHz	2.3	deg	
125.0 Hz	-0.3	deg	1.600 kHz	0.0	deg	20.000kHz	2.9	deg	
160.0 Hz	-0.3	deg	2.000 kHz	0.0	deg				
200.0 Hz	-0.3	deg	2.500 kHz	0.1	deg				

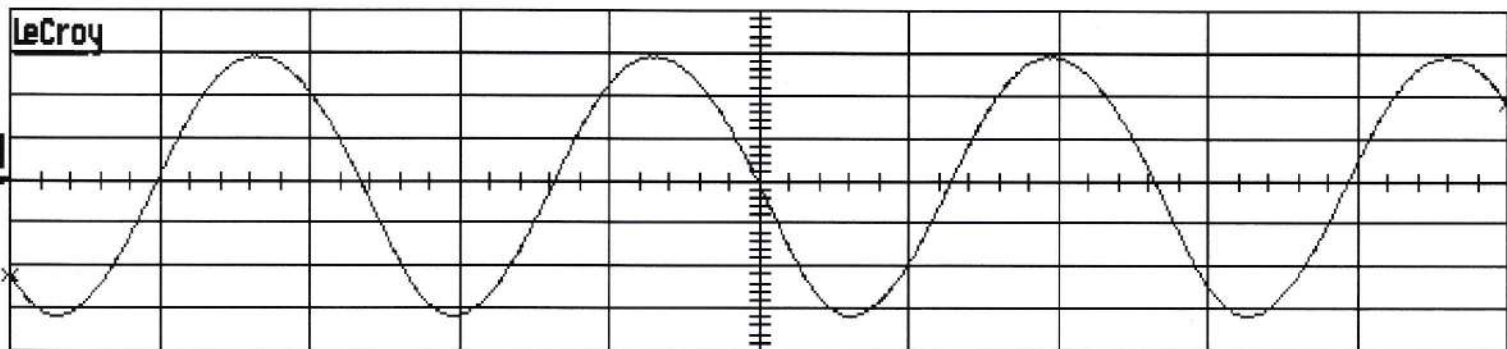
RATIO A/G	FREQ	GA	GEN:SINE	1.594	V	1.000 kHz	Ap
16.82dB	996.57 Hz						

RATIO A/B	FREQ	B	GEN:SINE	1.594	V	1.000 kHz	Ap
Low dB	Low Hz						

NOISE A	UN-WTD	22 Hz - 22 kHz	Ap
105.5 uV	GEN:SINE	1.594 V 1.000 kHz	

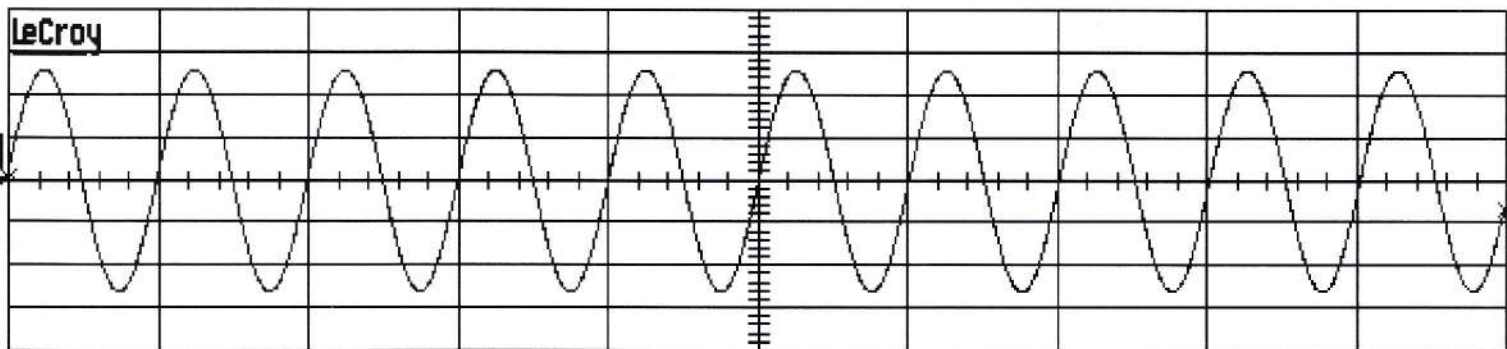
NOISE A	UN-WTD	400 Hz - 22 kHz	Ap
13.86 uV	GEN:SINE	1.594 V 1.000 kHz	

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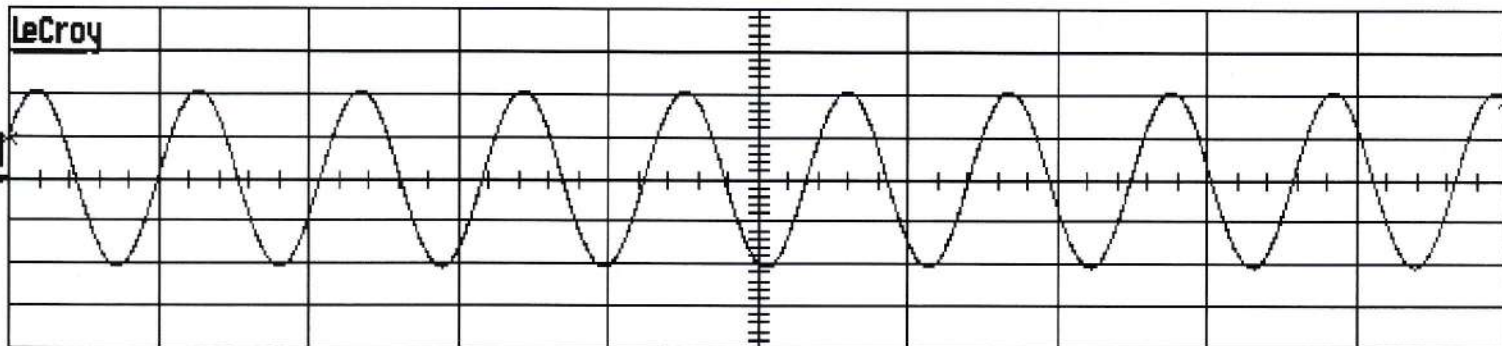
2 μs 1.00 V

pkpk(1)	6.09 V	Freq(1)	188.577 kHz
sdev(1)	2.178 V	period(1)	5.3029 μs
rms(1)	2.178 V	width(1)	2.7758 μs
cmean(1)	-2mV	rise(1)	1.5580 μs
csdev(1)	2.135 V	Fall(1)	1.5292 μs
crms(1)	2.135 V	r20-80%(1)	1.0744 μs
top(1)	2.88 V	F80-20%(1)	1.0692 μs
base(1)	-3.11 V	over+(1)	0.95 %
ampl(1)	5.99 V	over-(1)	0.82 %
mean(1)	1mV	xamn(1)	-1.37131 μs
minimum(1)	-3.16 V	xamx(1)	1.30099 μs
maximum(1)	2.94 V	delay(1)	-55.1 ns
area(1)	23.813 nVs	cycles(1)	3



1 10 ps 1.00 V

pkpk(1)	5.22 V	Freq(1)	99.549 kHz
sdev(1)	1.826 V	period(1)	10.0453 μ s
rms(1)	1.826 V	width(1)	4.9943 μ s
cmean(1)	-3mV	rise(1)	2.9021 μ s
csdev(1)	1.822 V	Fall(1)	2.9079 μ s
crms(1)	1.822 V	r20-80%(1)	2.0253 μ s
top(1)	2.55 V	F80-20%(1)	2.0204 μ s
base(1)	-2.57 V	over+(1)	0.83 %
ampl(1)	5.12 V	over-(1)	1.13 %
mean(1)	-1mV	xamn(1)	-2.55085 μ s
minimum(1)	-2.63 V	xamx(1)	-7.58408 μ s
maximum(1)	2.59 V	delay(1)	-5.0359 μ s
area(1)	-148.188 nVs	cycles(1)	9

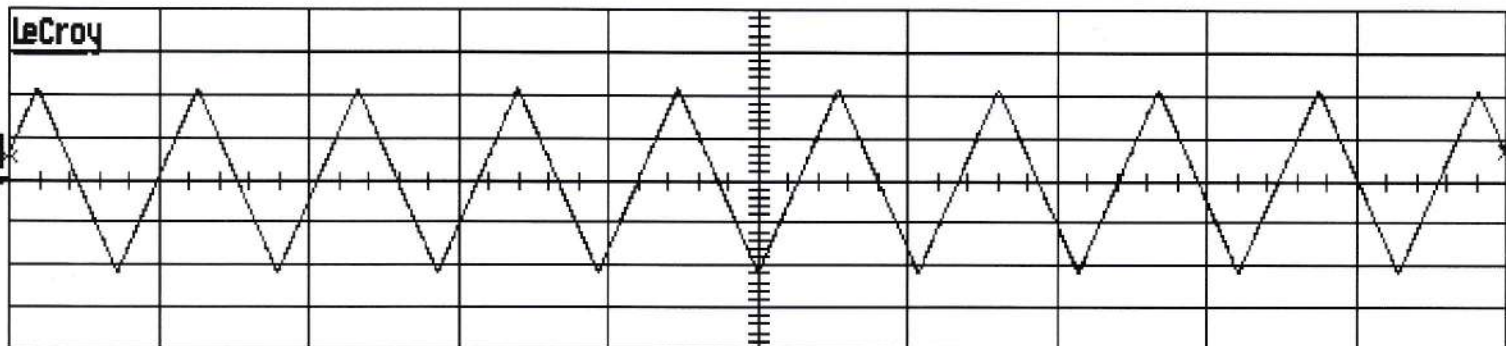


1 50 ms 2.00 V

pkpk(1)	8.38 V	Freq(1)	18.46 Hz
sdev(1)	2.924 V	period(1)	54.1700 ms
rms(1)	2.925 V	width(1)	27.3265 ms
cmean(1) ✓	-3mV	rise(1)	15.3107 ms
csdev(1) ✓	2.906 V	Fall(1)	15.3170 ms
crms(1) ✓	2.906 V	r20-80%(1)	10.5647 ms
top(1)	4.09 V	F80-20%(1)	10.5753 ms
base(1)	-3.99 V	over+(1)	1.23 %
ampl(1)	8.07 V	over-(1)	2.48 %
mean(1)	85mV	xamn(1)	-13.6783 ms
minimum(1)	-4.19 V	xamx(1)	-40.7963 ms
maximum(1)	4.19 V	delay(1)	-27.3725 ms
area(1)	42.5078 mVs	cycles(1)	8

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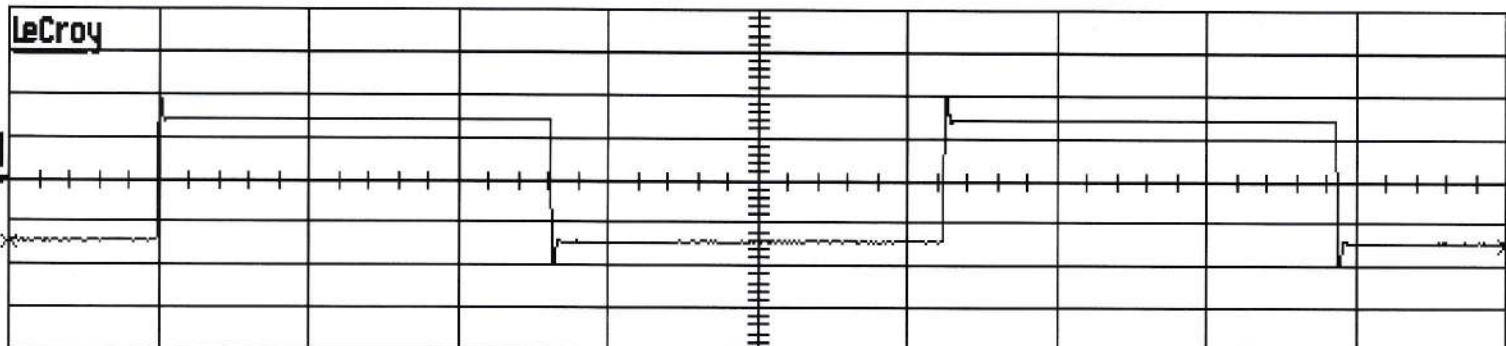


1 ms 2.00 V

pkpk(1)	8.75 V	Freq(1)	934.92 Hz
sdev(1)	2.496 V	period(1)	1.06961 ms
rms(1)	2.498 V	width(1)	531.24 μ s
cmean(1)	0 mV	rise(1)	427.98 μ s
csdev(1)	2.480 V	Fall(1)	428.14 μ s
crms(1)	2.480 V	r20-80%(1)	318.53 μ s
top(1)	4.38 V	F80-20%(1)	319.14 μ s
base(1)	-4.38 V	over+(1)	0.00 %
ampl(1)	8.75 V	over-(1)	0.00 %
mean(1)	104 mV	xamn(1)	-269.463 μ s
minimum(1)	-4.38 V	xamx(1)	-804.258 μ s
maximum(1)	4.38 V	delay(1)	-535.81 μ s
area(1)	1.03861 mVs	cycles(1)	8

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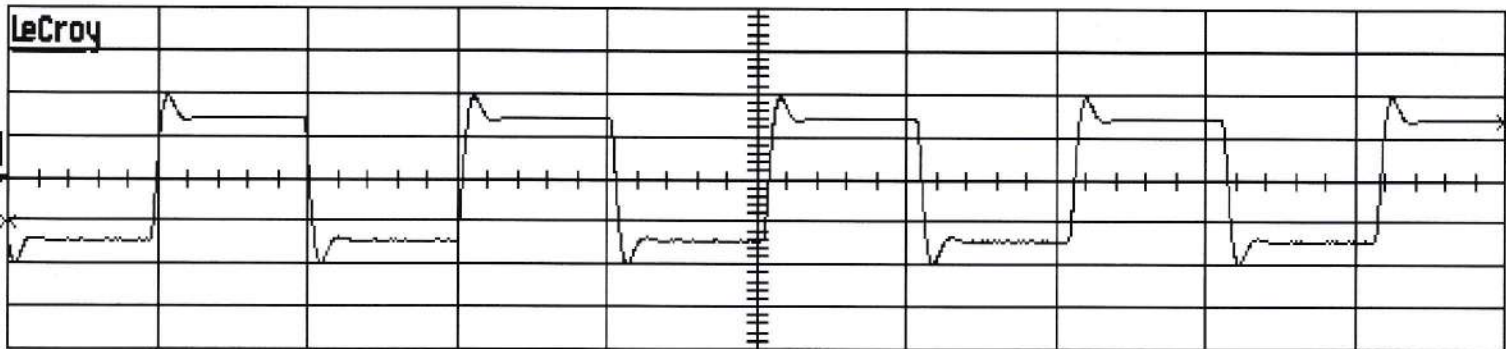


0.2 ms 2.00 V

pkpk(1)	7.88 V	Freq(1)	951.91 Hz
sdev(1)	2.850 V	period(1)	1.05052 ms
rms(1)	2.854 V	width(1)	525.779 μ s
cmean(1)	0mV	rise(1)	2.585 μ s
csdev(1)	2.853 V	Fall(1)	2.525 μ s
crms(1)	2.853 V	r20-80%(1)	1.807 μ s
top(1)	2.85 V	F80-20%(1)	1.800 μ s
base(1)	-2.88 V	over+(1)	17.96 %
ampl(1)	5.72 V	over-(1)	19.66 %
mean(1)	144mV	xamn(1)	529.969 μ s
minimum(1)	-4.00 V	xamx(1)	4.0727 μ s
maximum(1)	3.88 V	delay(1)	-61 ns
area(1)	287.438 μ Vs	cycles(1)	1

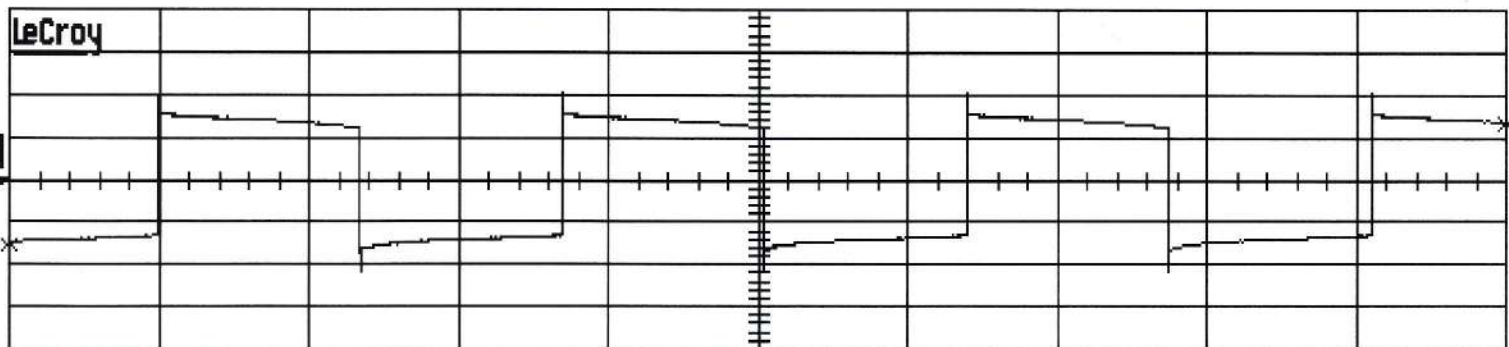
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50 μs 2.00 V

pkpk(1)	7.94 V	Freq(1)	9.7800 kHz
sdev(1)	2.874 V	period(1)	102.250 μs
rms(1)	2.875 V	width(1)	51.2094 μs
cmean(1)	-2mV	rise(1)	2.5740 μs
csdev(1)	2.869 V	Fall(1)	2.5450 μs
crms(1)	2.869 V	r20-80%(1)	1.8240 μs
top(1)	2.85 V	F80-20%(1)	1.7911 μs
base(1)	-2.88 V	over+(1)	19.05 %
ampl(1)	5.72 V	over-(1)	19.66 %
mean(1)	-53mV	xamn(1)	-47.3268 μs
minimum(1)	-4.00 V	xamx(1)	4.33916 μs
maximum(1)	3.94 V	delay(1)	-76.6 ns
area(1)	-26.6928 μVs	cycles(1)	4



1 20 ms 2.00 V

pkpk(1)	8.56 V	Freq(1)	18.50 Hz
sdev(1)	2.810 V	period(1)	54.0443 ms
rms(1)	2.810 V	width(1)	27.0344 ms
cmean(1)	-2mV	rise(1)	3.1 μ s
csdev(1)	2.810 V	Fall(1)	3.4 μ s
crms(1)	2.810 V	r20-80%(1)	2.2 μ s
top(1)	2.85 V	F80-20%(1)	2.2 μ s
base(1)	-2.75 V	over+(1)	23.91 %
ampl(1)	5.60 V	over-(1)	29.01 %
mean(1)	-16mV	xamn(1)	27.0404 ms
minimum(1)	-4.38 V	xamx(1)	4.77 μ s
maximum(1)	4.19 V	delay(1)	0.0 μ s
area(1)	-3.18250 mVs	cycles(1)	3

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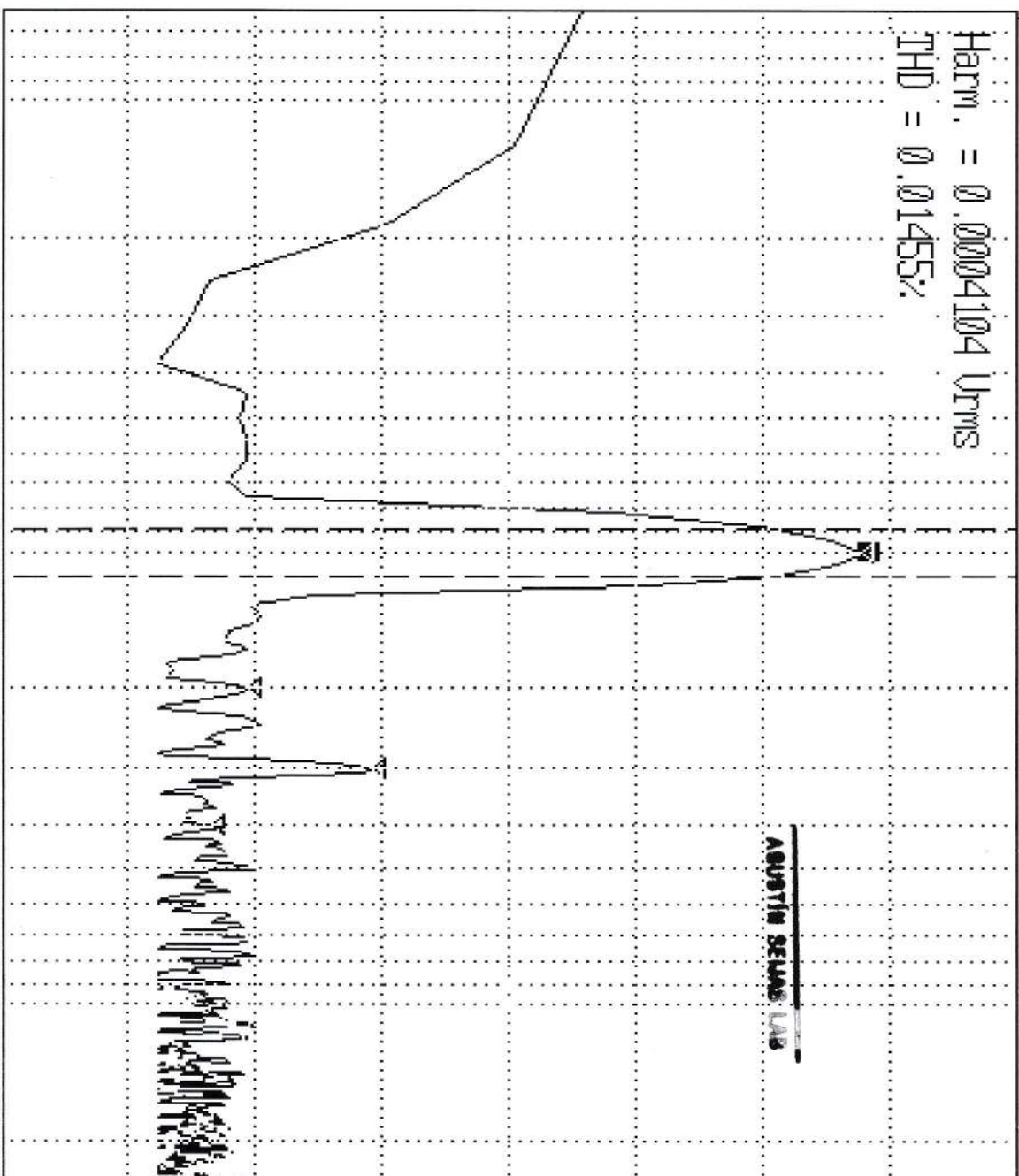
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1.00000 kHz $\gamma = 2.819$ μrms

LogMag Spec 0

Harm. = 0.0004104 μrms

THD = 0.01455%



62.5 Hz

25.0000 kHz

Top = 50.1187 μrms 20 dB/div Wndo: BMH

File= Live

RUN

16 dB

No Avg.

Span

25 kHz

Linewidth

62.5 Hz

Acq. Time

16.00 ms

Full

Span:



Start Freq.

0.0 kHz

Center Freq.

12.5000 kHz

Silicon Carbide (SiC) JFET – EliteSiC, Power N-Channel, TO247-4, 750 V, 4.8 mohm

UJ4N075005K4S

Description

onsemi's UJ4N075005K4S is a 750 V, 4.8 mΩ High-Performance Gen 4 Normally-On SiC JFET Transistor. This device exhibits Ultra-low On resistance ($R_{DS(ON)}$) in a TO247-4L Package, making it an ideal fit to address the Challenging Thermal Constraints of Solid-state Circuit Breakers and Relay Applications. Additionally, the JFET is a Robust Device Technology Capable of the High-Energy Switching Required in Circuit Protection Applications.

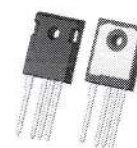
Features

- Single Digit On-Resistance
- Operating Temperature: 175 °C (Max)
- High Pulse Current Capability
- Excellent Device Robustness
- Silver-Sintered Die Attach for Excellent Thermal Resistance
- Low Intrinsic Capacitance
- Short Circuit Rated
- This Device is Pb-Free, Halogen Free and is RoHS Compliant

Typical Applications

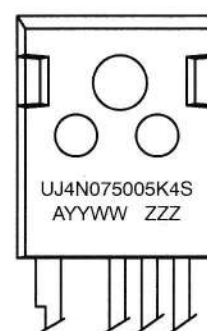
- Solid State / Semiconductor Circuit Breaker
- Solid State / Semiconductor Relay
- Battery Disconnects
- Surge Protection
- Inrush Current Control
- Induction Heating

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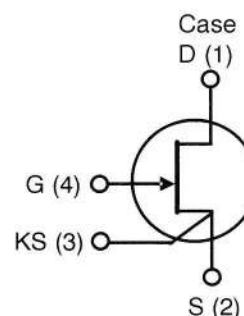
TO247-4
CASE 340AN

MARKING DIAGRAM



UJ4N075005K4S	= Specific Device Code
A	= Assembly Location
YY	= Year
WW	= Work Week
ZZZ	= Lot ID

PIN CONNECTIONS



ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.